

Search Notes

Application/Control No.

10/622,663

Examiner

Betsy L. Deppe

Applicant(s)/Patent under
Reexamination

AGRAWAL, AVNEESH

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	132	12/19/2005	BD
375	133	12/19/2005	BD
375	135	12/19/2005	BD
375	136	12/19/2005	BD
375	260	12/19/05	BD
375	346	12/19/2005	BD
375	347	12/19/2005	BD
375	349	12/19/2005	BD
370	208, 210	12/19/2005	BD
370	343, 344	12/19/2005	BD
455	63. 296	12/19/2005	BD
455	422.1	12/19/2005	BD
455	442, 501	12/19/2005	BD
455	450, 451	12/19/2005	BD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same as	above	3/19/2007	BD

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor name search	12/19/2005	BD
Text search (USPAT; US-PGPUB; JPO; EPO; DERWENT)	12/20/2005	BD
Updated class/subclass search	8/29/2006	BD
Text search (USPAT; US-PGPUB; JPO; EPO; DERWENT)	8/29/2006	BD
Updated class/subclass search of 8/29/06	3/19/2007	BD

Search Notes (continued)

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Class	Subclass	Date	Examiner
375	340	8/29/2006	BD
455	436	8/29/2006	BD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR